Applicant(s)/Patent Under Application/Control No. Reexamination 10/736,336 KIM ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Anh T. Mai 2832 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 336/200 US-6,927,664 08-2005 Nakatani et al. Α US-В US-С US-D US-Ε US-F

FOREIGN PATENT DOCUMENTS

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